

PRODUCT / PROCESS CHANGE NOTIFICATION

1. PCN basic data

1.1 Company		STMicroelectronics International N.V
1.2 PCN No.	MDG/19/10986	
1.3 Title of PCN	ST Shenzhen (China) TSSOP 20 package Back-End line – additional products	
1.4 Product Category	STM8L10, STM8L15, STM32F04 Products in TSSOP20 package.	
1.5 Issue date	2019-06-28	

2. PCN Team

2.1 Contact supplier	
2.1.1 Name	ROBERTSON HEATHER
2.1.2 Phone	+1 8475853058
2.1.3 Email	heather.robertson@st.com
2.2 Change responsibility	
2.2.1 Product Manager	Ricardo Antonio DE SA EARP
2.1.2 Marketing Manager	Veronique BARLATIER
2.1.3 Quality Manager	Pascal NARCHE

3. Change

3.1 Category	3.2 Type of change	3.3 Manufacturing Location
Materials	Any change on substrate (part number, supplier, plant, design or composition of any layer, etc..)	ST Shenzhen China

4. Description of change

	Old	New
4.1 Description	Back-end sources: - Amkor ATP Philippines	Back-end sources: - Amkor ATP Philippines - ST Shenzhen China added
4.2 Anticipated Impact on form,fit, function, quality, reliability or processability?	- Lead color and surface finish change depending on lead finishing. - Package darkness changes depending on molding compound. - Pin1 identifier might change in terms of form and positioning. - Marking position and size could be different upon assembly site, without any loss of information.	

5. Reason / motivation for change

5.1 Motivation	Today, production is only made in AMKOR ATP (Philippines). In order to ensure top class service for our customers, given the continued growth of the STM32 & STM8 families, ST Microcontrollers Division will increase production capacity and improve flexibility through the qualification of an additional assembly source.
5.2 Customer Benefit	CAPACITY INCREASE

6. Marking of parts / traceability of change

6.1 Description	Country of origin marked on package top side is changing from PHL to CHN.
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7. Timing / schedule

7.1 Date of qualification results	2018-06-28
7.2 Intended start of delivery	2019-07-26
7.3 Qualification sample available?	Upon Request

8. Qualification / Validation

8.1 Description	10986 MDG-MCD RER1512 STM8S-STM32 TSSOP20 - ST SHZ-PCN9299- reliability evaluation report V2.0.pdf		
8.2 Qualification report and qualification results	Available (see attachment)	Issue Date	2019-06-28

9. Attachments (additional documentations)
10986 Public product.pdf 10986 MDG-MCD RER1512 STM8S-STM32 TSSOP20 - ST SHZ-PCN9299- reliability evaluation report V2.0.pdf 10986 PCN10986_Additional information.final.pdf

10. Affected parts		
10. 1 Current		10.2 New (if applicable)
10.1.1 Customer Part No	10.1.2 Supplier Part No	10.1.2 Supplier Part No
	STM32F042F4P6	
	STM32F042F4P6TR	
	STM32F042F6P6	
	STM32F042F6P6TR	
	STM32F042F6P7	
	STM32F070F6P6	
	STM32F070F6P6TR	
	STM8L051F3P6	
	STM8L051F3P6TR	
	STM8L101F2P3	
	STM8L101F2P3TR	
	STM8L101F2P6	
	STM8L101F2P6TR	
	STM8L101F3P3	
	STM8L101F3P6	
	STM8L101F3P6TR	
	STM8L151F2P6	
	STM8L151F2P6TR	
	STM8L151F3P3	
	STM8L151F3P6	
	STM8L151F3P6TR	

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MDG- MCD RER1512

Reliability Report

Qualification Type : ASSEMBLY LINE QUALIFICATION, NEW BILL OF MATERIALS

TSSOP20 - ST SHENZHEN

STM8S-STM32 - Dice 767, 444, 758

(PCN MMS-MCD/15/9299 dated 16 Jun 2016)

(PCN MMS-MCD/19/10986 dated 21 Jun 2019)

Product / Process & Package Information	Die 767	Die 444	Die 758
Commercial Product:	STM8S003F3P6	STM32F030F4P6	STM8L051F3P6
Product Line:	STM8S die 767	STM32F die 444	STM8L die 758
Product Description:	Micro 8Bits	Micro 32Bits	Micro 8Bits
Finish Good Code:	IS8S003F3P6\$C3	IS32F030F4P6\$C2	IS8L051F3P6\$C2
Mask Set Revision:	F767XXXY	F444XXXA	F758XXXZ
Silicon Process Technology:	CMOSF9GO1	0.18 Gen.Emb.Flash logic TSMC	CMOSF9GO2
Wafer Fabrication Location:	ST Rousset 8 France	TSMC Fab 8 Taiwan	ST Rousset 8 France
Electrical Wafer Sort Test Plant Location:	ST MICROELECTRONICS Ang Mo Kio EWS Singapore	ARDENTEC EWS Taiwan	ARDENTEC EWS Taiwan
Package:	TSSOP 20 BODY 4.4 PITCH 0.65		
Assembly Plant location:	SHENZHEN (China)		
Final Test plant location:	SHENZHEN (China)		

Approval List V1.0			
Function	Location	Name	Date
Division Q&R Responsible	ST Rousset	Gisèle SEUBE	08 Feb 17
Division Quality Manager	ST Rousset	Pascal NARCHE	08 Feb 17

Approval List V2.0			
Function	Location	Name	Date
Division Q&R Responsible	ST Rousset	Gisèle SEUBE	18 jun 19
Division Quality Manager	ST Rousset	Pascal NARCHE	18 jun 19

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1 RELIABILITY RESULTS OVERVIEW

1.1 Objectives

This report summarizes the reliability results for TSSOP20 2x3.35 package manufactured at ST Shenzhen (China).

Test vehicles are described here below:

Product	Package
STM8S003F3P6	TSSOP 20 BODY 4.4 PITCH 0.65
STM32F030F4P6	TSSOP 20 BODY 4.4 PITCH 0.65
STM8L051F3P6	TSSOP 20 BODY 4.4 PITCH 0.65

1.2 Context

Today production is only issued from AMKOR ATP (Philippines). In order to ensure top class service for our customers, given the continued growth of the STM32 & STM8 families, ST Microcontrollers Division will increase production capacity and improve flexibility through the qualification of an additional assembly source. Changes are described in the below table on TSSOP20:

New Bill of Materials changes are described here below:

Old	New
Current assembly plant : AMKOR ATP (Philippines)	Current assembly plant, AMKOR ATP (Philippines), remains unchanged.
	Additional assembly plant : ST Shenzhen (China)
Current Bill Of Materials : - Wire Bonding : 0.8 mil Au - Glue : 8290 Ablestik - Resin : G700K - Leadfinishing : Rough PPF	Additional Bill Of Materials : - Wire Bonding : 0.8 mil Ag - Glue : 8601-S25 Ablestik - Resin : G700KC - Leadfinishing : PPF

(*) Lead color and surface finish change depending on lead finishing

Changes are qualified using the standard STMicroelectronics Corporate Procedures for Quality and Reliability, in full compliancy with the JESD-47 international standard.

1.3 Conclusion

All reliability tests have been completed with positive results for 767 and 444 dice. Neither functional nor parametric rejects were detected at final electrical testing.

Bond Pad Validation has been completed with positive results for 758 die,

According to the positive Bond Pad Validation and reliability results, the qualification is granted for TSSOP20 at ST Shenzhen.

2 RELIABILITY TEST VEHICLES Characteristics

2.1 Reliability Test vehicles description

Package line	Assembly Line Package	Device (Partial RawLine Code)	Diffusion Process	Number of Lots
TSSOP	20L	STM8S (YA*767) STM32 (YA*444) STM8L (YA*758)	F9GO1 TSMC 0.18µm F9GO2	3 3 1 (Bond Pad Validation)

2.2 Reliability Information

Lot ID	Lot 1	Lot 2	Lot 3	Lot 4	Lot 5	Lot 6	Lot 7
Die Name /cut:	767			444			758
Diffusion Lot Number:	VG631250	VG631250	VG631250	9U628038	98546004	9U628038	VG848634
Trace Code:	GK6411Y9	GK6411Y9	GK6411Y9	GK6411YA	GK6411YA	GK6411YA	NA
Assy lot number	GK6411Y9RQ	GK6411Y9RJ	GK6411Y9RL	GK6411YARM	GK6411YARK	GK6411YARM	G848634H1
Raw Line Code Package:	C5YA*767ISX Y	C5YA*767ISX Y	C5YA*767ISX Y	C6YA*444ISX 1	C6YA*444ISX 1	C6YA*444ISX 1	C3YA*758ISX Z
Reliability Lab location :	ST Rousset (France)	ST Shenzhen (China)		ST Rousset (France)	ST Shenzhen (China)		

2.3 Front-End information

Front-End	767	444	758
Wafer Diameter:	8 inches	8 inches	8 inches
Wafer Thickness:	375 +/-25 μm	381 +/-25 μm	375 +/-25 μm
Die Size:	1.334 X 2.210 μm	2.458 X 2.360 μm	1.562 X 2.238 μm
Scribe Line size x/y:	80 X 80 μm	80 X 80 μm	80 X 80 μm
Pad Die Size /Pad type:	65 X 108 μm	65 X 70 μm	65 X 108 μm
Metal Layers Number /Materials /Thickness:	Metal 1 TaN/Ta/Cu 0.280 μm Metal 2 TaN/Ta/Cu 0.350 μm Metal 3 TaN/Ta/Cu 0.350 μm Metal 4 Ti/AlCu/TxTN 0.900 μm	Metal 1 Tin/AlCu/Tin 0.450 μm Metal 2 Tin/AlCu/Tin 0.450 μm Metal 3 Tin/AlCu/Tin 0.450 μm Metal 4 Tin/AlCu/Tin 0.450 μm Metal 5 Tin/AlCu/Tin 0.875 μm	Metal 1 TaN/Ta/Cu 0.280 μm Metal 2 TaN/Ta/Cu 0.350 μm Metal 3 TaN/Ta/Cu 0.350 μm Metal 4 TaN/Ta/Cu 0.350 μm Metal 5 Ti/AlCu/TxTN 0.900 μm
Passivation Layers Thickness:	USG + NitUV (HFP USG+UV Nitride)	HDPox 10kA+SRO 1.5kA+PESIN 6kA	USG + NitUV (HFP USG+UV Nitride)
Back Metal Finishing	RAW SILICON - BACK GRINDING	RAW SILICON - BACK GRINDING	RAW SILICON - BACK GRINDING

2.4 Back-End information

Back-End	767	444	758
Assembly Plant Location/ Address:	Shenzen STS Microelectronics co.,Ltd 16, Tao Hua Rd. Futian Free Trade Zone Shenzhen, P.R. China 518048	Shenzen STS Microelectronics co.,Ltd 16, Tao Hua Rd. Futian Free Trade Zone Shenzhen, P.R. China 518048	Shenzen STS Microelectronics co.,Ltd 16, Tao Hua Rd. Futian Free Trade Zone Shenzhen, P.R. China 518048
Die Thickness after Back grinding:	280 μm +/-20μm	280 μm +/-20μm	280 μm +/-20μm
Die sawing method:	Step cut	Step cut	Step cut
Die attach material: Type: Supplier:	Glue 8601S-25 Loctite Ablestik Henkel	Glue 8601S-25 Loctite Ablestik Henkel	Glue 8601S-25 Loctite Ablestik Henkel
Lead frame material: L/F Finishing Type: Die paddle size: Supplier:	TSSOP 20L COPER HDMt OpA C7025 NiPdAu 2x3.35 ASM	TSSOP 20L COPER HDMt OpB C7025 NiPdAu 2x4.20 ASM	TSSOP 20L COPER HDMt OpA C7025 NiPdAu 3x4.20 ASM
Wire bonding: Type /Diameter: Supplier:	AG 96,5% WIRE 0.8MIL MKE	AG 96,5% WIRE 0.8MIL MKE	AG 96,5% WIRE 0.8MIL MKE
Pitch:	80μm	80μm	80μm
POA:	0087225	0087225	0087225
Molding Compound Supplier:	EME-G700KC SUMITOMO	EME-G700KC SUMITOMO	EME-G700KC SUMITOMO
Package Moisture Sensitivity Level (JEDEC J-STD020D):	1	1	1

3 RELIABILITY RESULTS SUMMARY

3.1 Die oriented test

	Die Related Tests					Results TSSOP20	
Description	Test/Method	Conditions	Sample Size	Criteria	Readout / Duration	767	444
						Lot1	Lot4
Electrostatic discharge – Charge Device Model							
ESD CDM	ANSI/ESD STM5.3.1	500V 1KV	3 units	500V for dice 444 1KV for 767	NA	0/3	0/3

3.2 Package Oriented Test

	Package Related Tests					Results TSSOP20					
Description	Test/Method	Conditions	Sample Size	Criteria	Readout / Duration	767			444		
						Lot 1	Lot 2	Lot 3	Lot 4	Lot 5	Lot 6
Preconditioning: moisture sensitivity level 1											
PC	J-STD-020 JESD22-A113	MSL1	241 units	Electrical test: A0/R1 (Accepted 0 reject/ Rejected 1 reject)	NA	0/231	0/231	0/231	0/231	0/231	0/231
		Delamination				0/60	0/231	0/231	0/60	0/231	0/231
High Temperature Storage Life (No preconditioning)											
HTSL	JESD 22-A103	150°C	77 units	Elect test A0/R1	1000h	0/77	0/77	0/77	0/77	0/77	0/77
Thermal Cycling after Preconditioning											
TC	JESD 22-A104	-65c/+150°c	77 units	Elect test A0/R1	500cy	0/77	0/77	0/77	0/77	0/77	0/77
					1000cy	0/77	0/77	0/77	0/77	0/77	0/77
Wire Bond Shear after Thermal Cycling											
Wire Bond Shear	AEC Q100-001	Min bond shear 15g after TC	10 wires x 3 units	A0/R1	After TC 500cy TC 1000cy	0/30 0/30	0/30 0/30	0/30 0/30	0/30 0/30	0/30 0/30	0/30 0/30
Wire Bond Pull after Thermal Cycling											
Wire Bond Pull	Mil Std 883 Method 2011	Minimum pull strength after TC=3 grams after TC	10 wires x 3 units	A0/R1	After TC 500cy TC 1000cy	0/30 0/30	0/30 0/30	0/30 0/30	0/30 0/30	0/30 0/30	0/30 0/30



Autoclave / Unbiased Highly Accelerated Temperature and Humidity Stress after Preconditioning											
AC	JESD 22A102	121°C ,100% 2Atm RH	77 units	Elect test A0/R1	96h 192h		0/77 0/77	0/77 0/77		0/77 0/77	0/77 0/77
UHAST	JESD 22 A118	130°C ,85% 2Atm RH	77 units	Elect test A0/R1	96h	0/77			0/77		
Temperature Humidity Bias / Storage after Preconditioning											
THB	JESD 22A101	85°C/85%RH Bias	77 units	Elect test A0/R1	1000h		0/77	0/77		0/77	0/77
THS	JESD 22A118	85°C/85%RH UnBias	77 units	Elect test A0/R1	1000h	0/77			0/77		
Construction Analysis											
CA	Construction Analysis including : -Wire bond shear -Wire bond pull -Solderability -Physical Dimension	JESD 22B102 JESDB100/ JESDB108	50		No concern		No concern		No concern		No concern

4 APPLICABLE AND REFERENCE DOCUMENTS

ADCS/DMS 0061692 :	Reliability Tests And Criteria For Qualifications
SOP 2.6.2:	Process qualification and transfer management
SOP 2.6.7:	Product Maturity Level
SOP 2.6.9:	Package and process maturity management in Back End
SOP 2.6.11:	Program management from product qualification
SOP 2.6.19:	Process maturity level
ANSI-ESD STM5.3.1:	Electrostatic discharge (ESD) sensitivity testing charge device model (CDM)
JESD 22-A103	High Temperature Storage Life
J-STD-020D:	Moisture/reflow sensitivity classification for non-hermetic solid state surface mount devices
JESD22-A113:	Preconditioning of non-hermetic surface mount devices prior to reliability testing
JESD22-A102:	Autoclave test (pressure pot)
JESD22-A118:	Unbiased Highly Accelerated Temperature and Humidity Stress Temperature Humidity Storage – No Bias (ST customize)
JESD22-A104:	Temperature cycling
JESD22-A101:	Temperature Humidity Bake
JESD 22B102:	Solderability test
JESD22B100/B108:	Physical dimension

5 GLOSSARY AND TESTS DESCRIPTION

PC	Preconditioning (solder simulation)
THB	Temperature Humidity Bias
THS	Temperature Humidity Storage – No Bias
TC	Temperature cycling
AC	Autoclave test (pressure pot)
UHASt	Unbiased Highly Accelerated Temperature and Humidity Stress
HTSL	High temperature storage life
ADCS/DMS	ST Advanced Documentation Controlled system/ Documentation Management system
ESD CDM	Electrostatic discharge (charge device model)
CA	Construction Analysis

6 REVISION HISTORY

Version	Date	Author	Comment
1.0	18 Feb 17	Cedric CHASTANG	Initial release for qualification
2.0	18 Jun 19	Cedric CHASTANG	Qualification of F9G02 devices by Bond Pad Validation

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**ST Shenzhen (China) TSSOP 20 package Back-End line
- Additional products**

MDG - Microcontrollers Division (MCD)

What are the changes?

	Existing manufacturing site / line		Added manufacturing site / line
Assembly site	Amkor ATP Philippines		ST Shenzhen China
Leadframe (1)	LF FOR TSSOP 20 3X4.2 PPF		LF FOR TSSOP 20 3X4.2 PPF
Resin (2)	SUMITOMO G700K		SUMITOMO G700KC
Glue	GLUE D/A ABLESTIK 8290		GLUE D/A ABLESTIK 8601S25
Wire	Gold 0.8mil		Silver 96.5% 0.8mil
Enhanced Traceability in marking	No digit		2 digits

(1) Lead color and surface finish change depending on leadfinishing.

(2) Package darkness changes depending on molding compound.

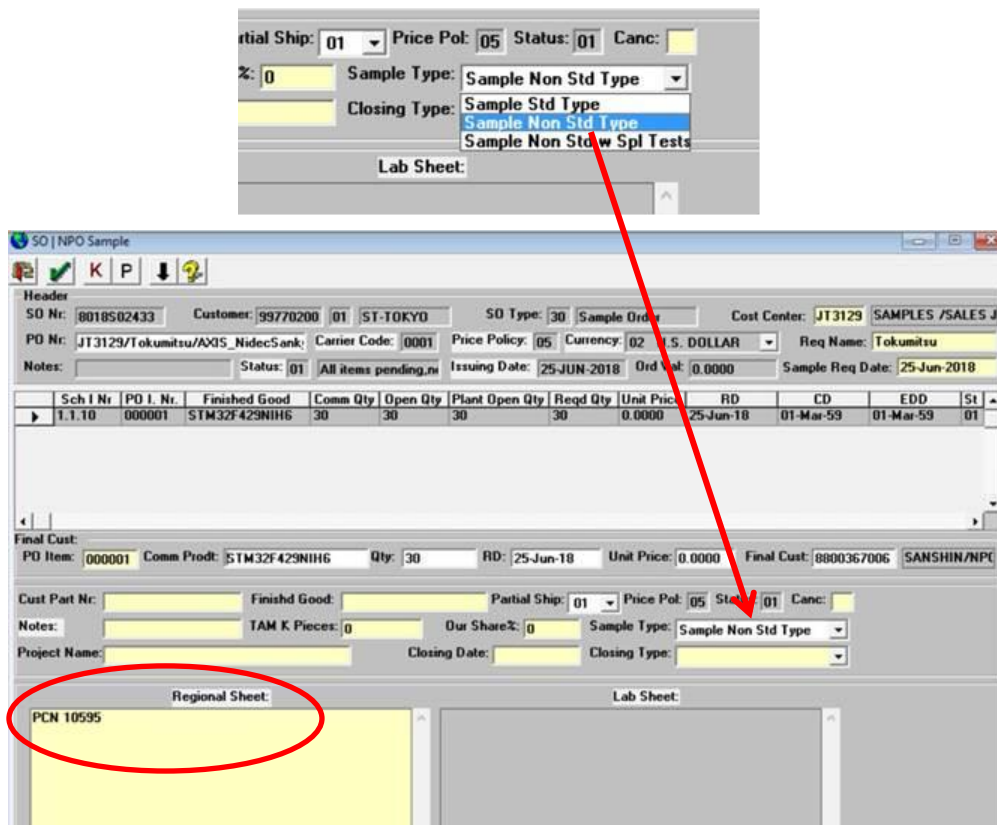
Pin1 identifier can change in terms of form and positioning.

Marking position and size could be different upon assembly site, without any loss of information.

How to order samples?

For all samples request linked to this PCN, please:

- place a **Non-standard** sample order (choose Sample Non Std Type from pull down menu)
- insert the PCN number “**PCN10986**” into the NPO Electronic Sheet/**Regional Sheet**
- request sample(s) through Notice tool, indicating a single Commercial Product for each request



Partial Ship: 01 Price Pol: 05 Status: 01 Canc: []

%: 0 Sample Type: Sample Non Std Type

Closing Type: Sample Std Type

Sample Non Std Type

Sample Non Std w Spl Tests

Lab Sheet: []

SO | NPO Sample

Header

SO Nr: 8018S02433 Customer: 99770200 01 ST-TOKYO SO Type: 30 Sample Order Cost Center: JT3129 SAMPLES /SALES J

PO Nr: JT3129/Tokumitsu/AXIS_NidecSank Carrier Code: 0001 Price Policy: 05 Currency: 02 U.S. DOLLAR Req Name: Tokumitsu

Notes: Status: 01 All items pending,ni Issuing Date: 25-JUN-2018 Ord Val: 0.0000 Sample Req Date: 25-Jun-2018

Sch I Nr	PO I. Nr.	Finished Good	Comm Qty	Open Qty	Plant Open Qty	Reqd Qty	Unit Price	RD	CD	EDD	St
1.1.10	000001	STM32F429NIH6	30	30	30	30	0.0000	25-Jun-18	01-Mar-59	01-Mar-59	01

Final Cust: PO Item: 000001 Comm Prod: STM32F429NIH6 Qty: 30 RD: 25-Jun-18 Unit Price: 0.0000 Final Cust: 8800367006 SANSIN/NPC

Cust Part Nr: [] Finishd Good: [] Partial Ship: 01 Price Pol: 05 Status: 01 Canc: []

Notes: TAM K Pieces: 0 Our Share: 0 Sample Type: Sample Non Std Type

Project Name: [] Closing Date: [] Closing Type: []

Regional Sheet: PCN 10595

Lab Sheet: []

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PCN Title : ST Shenzhen (China) TSSOP 20 package Back-End line – additional products

PCN Reference : MDG/19/10986

Subject : Public Products List

Dear Customer,

Please find below the Standard Public Products List impacted by the change.

STM32F070F6P6TR	STM8L101F3P6	STM32F042F4P6TR
STM8L051F3P6TR	STM8L151F3P3	STM8L101F2P3TR
STM8L151F3P6TR	STM32F042F6P7	STM8L101F2P3
STM8L051F3P6	STM8L101F2P6	STM8L151F2P6TR
STM8L151F2P6	STM8L151F3P6	STM32F070F6P6
STM8L101F2P6TR	STM8L101F3P6TR	STM32F042F4P6
STM32F042F6P6	STM8L101F3P3	



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